



Integrated Device Technology, Inc.

# CMOS STATIC RAM 16K (4K x 4-BIT)

IDT6168SA  
IDT6168LA

## FEATURES:

- High-speed (equal access and cycle time)
  - Military: 15/20/25/35/45ns (max.)
  - Commercial: 15/20/25/35ns (max.)
- Low power consumption
- Battery backup operation—2V data retention voltage (IDT6168LA only)
- Available in high-density 20-pin ceramic or plastic DIP, 20-pin SOIC.
- Produced with advanced CMOS high-performance technology
- CMOS process virtually eliminates alpha particle soft-error rates
- Bidirectional data input and output
- Military product compliant to MIL-STD-883, Class B

## DESCRIPTION:

The IDT6168 is a 16,384-bit high-speed static RAM organized as 4K x 4. It is fabricated using IDT's high-performance, high-reliability CMOS technology. This state-of-the-art technology, combined with innovative circuit design techniques,

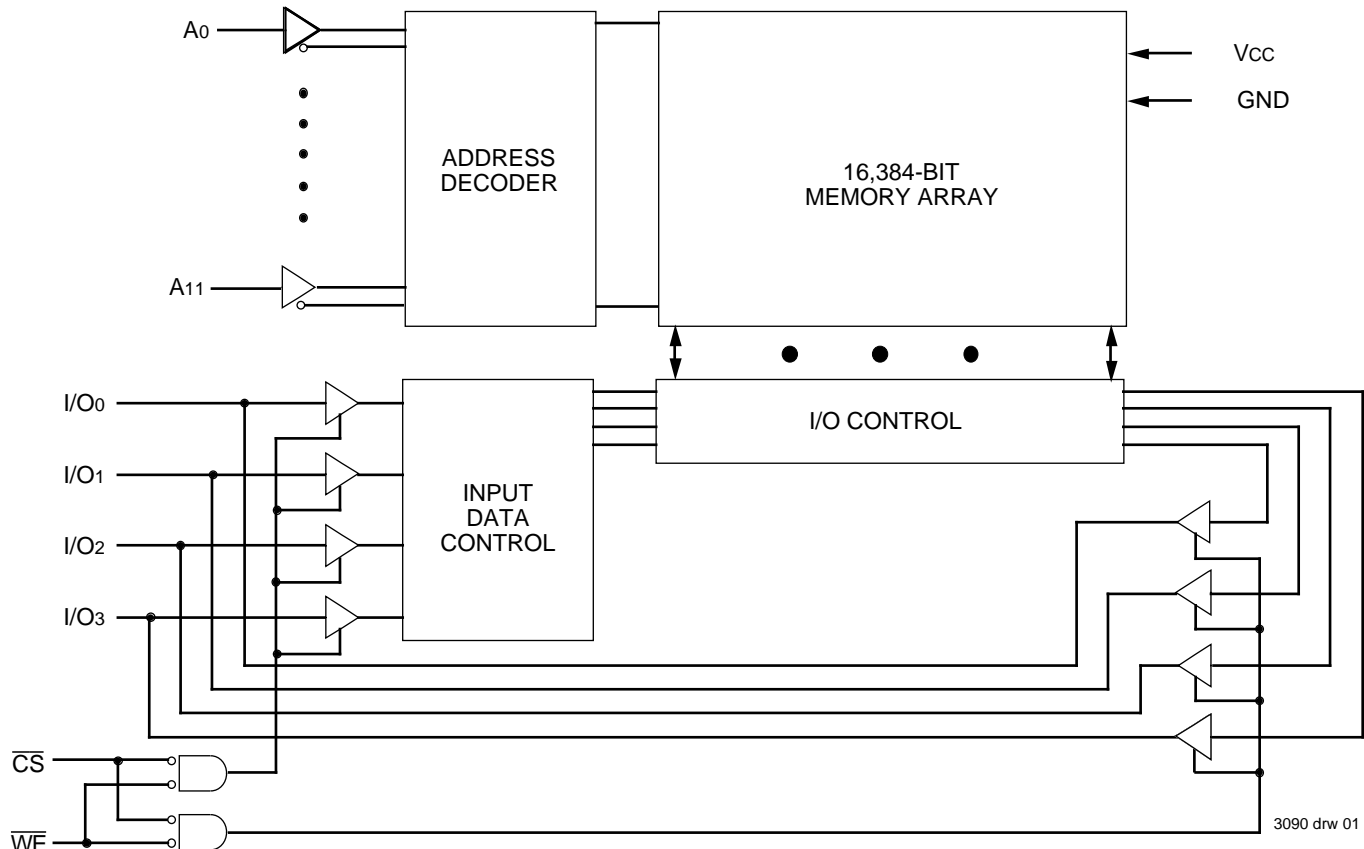
provides a cost-effective approach for high-speed memory applications.

Access times as fast 15ns are available. The circuit also offers a reduced power standby mode. When  $\overline{CS}$  goes HIGH, the circuit will automatically go to, and remain in, a standby mode as long as  $\overline{CS}$  remains HIGH. This capability provides significant system-level power and cooling savings. The low-power (LA) version also offers a battery backup data retention capability where the circuit typically consumes only 1 $\mu$ W operating off a 2V battery. All inputs and outputs of the IDT6168 are TTL-compatible and operate from a single 5V supply.

The IDT6168 is packaged in either a space saving 20-pin, 300-mil ceramic or plastic DIP, 20-pin SOIC providing high board-level packing densities.

Military grade product is manufactured in compliance with the latest revision of MIL-STD-883, Class B, making it ideally suited to military temperature applications demanding the highest level of performance and reliability.

## FUNCTIONAL BLOCK DIAGRAM

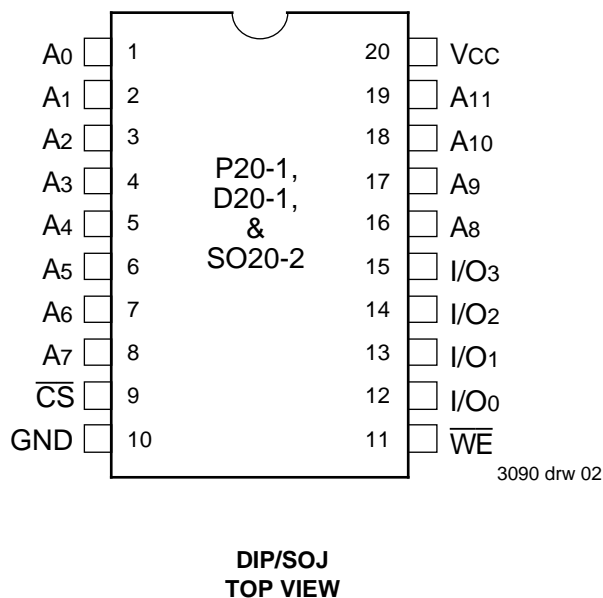


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## MILITARY AND COMMERCIAL TEMPERATURE RANGE

MAY 1996

## PIN CONFIGURATIONS



## PIN DESCRIPTIONS

Name	Description
A0–A11	Address Inputs
$\overline{CS}$	Chip Select
$\overline{WE}$	Write Enable
I/O0-3	Data Input/Output
VCC	Power
GND	Ground

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## CAPACITANCE (TA = +25°C, F = 1.0MHz)

Symbol	Parameter <sup>(1)</sup>	Conditions	Max.	Unit
C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> = 0V	7	pF
C <sub>I/O</sub>	I/O Capacitance	V <sub>OUT</sub> = 0V	7	pF

**NOTE:**  
1. This parameter is determined by device characterization, but is not production tested.

## TRUTH TABLE<sup>(1)</sup>

Mode	$\overline{CS}$	$\overline{WE}$	Output	Power
Standby	H	X	High-Z	Standby
Read	L	H	DOUT	Active
Write	L	L	DIN	Active

**NOTE:**  
1. H = V<sub>IH</sub>, L = V<sub>IL</sub>, X = Don't Care

## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

Symbol	Rating	Com'l.	Mil.	Unit
V <sub>TERM</sub>	Terminal Voltage with Respect to GND	-0.5 to +7.0	-0.5 to +7.0	V
T <sub>A</sub>	Operating Temperature	0 to +70	-55 to +125	°C
T <sub>BIAS</sub>	Temperature Under Bias	-55 to +125	-65 to +135	°C
T <sub>STG</sub>	Storage Temperature	-55 to +125	-65 to +150	°C
PT	Power Dissipation	1.0	1.0	W
I <sub>OUT</sub>	DC Output Current	50	50	mA

**NOTE:**  
1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

## RECOMMENDED DC OPERATING CONDITIONS

Symbol	Parameter	Min.	Typ.	Max.	Unit
VCC	Supply Voltage	4.5	5.0	5.5	V
GND	Supply Voltage	0	0	0	V
V <sub>IH</sub>	Input High Voltage	2.2	—	6.0	V
V <sub>IL</sub>	Input Low Voltage	-0.5 <sup>(1)</sup>	—	0.8	V

**NOTE:**  
1. V<sub>IL</sub> (min.) = -3.0V for pulse width less than 20ns, once per cycle.

## RECOMMENDED OPERATING TEMPERATURE AND SUPPLY VOLTAGE

Grade	Temperature	GND	VCC
Military	-55°C to +125°C	0V	5V ± 10%
Commercial	0°C to +70°C	0V	5V ± 10%

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### DC ELECTRICAL CHARACTERISTICS<sup>(1)</sup>

(V<sub>CC</sub> = 5.0V ± 10%, V<sub>LC</sub> = 0.2V, V<sub>HC</sub> = V<sub>CC</sub> - 0.2V)

Symbol	Parameter	Power	6168SA15		6168SA20 6168LA20		Unit
			Com'l.	Mil.	Com'l.	Mil.	
ICC1	Operating Power Supply Current $\overline{CS} \leq V_{IL}$ , Outputs Open, V <sub>CC</sub> = Max., f = 0 <sup>(2)</sup>	SA	110	120	90	100	mA
		LA	—	—	70	80	
ICC2	Dynamic Operating Current $\overline{CS} \leq V_{IL}$ , Outputs Open, V <sub>CC</sub> = Max., f = f <sub>MAX</sub> <sup>(2)</sup>	SA	145	165	120	120	mA
		LA	—	—	100	110	
ISB	Standby Power Supply Current (TTL Level) $\overline{CS} \geq V_{IH}$ , V <sub>CC</sub> = Max., Outputs Open, f = f <sub>MAX</sub> <sup>(2)</sup>	SA	55	60	45	45	mA
		LA	—	—	30	35	
ISB1	Full Standby Power Supply Current (CMOS Level) $\overline{CS} \geq V_{HC}$ , V <sub>CC</sub> = Max., V <sub>IN</sub> ≥ V <sub>HC</sub> or V <sub>IN</sub> ≤ V <sub>LC</sub> , f = 0 <sup>(2)</sup>	SA	20	20	20	20	mA
		LA	—	—	0.5	5	

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### DC ELECTRICAL CHARACTERISTICS (CONTINUED)<sup>(1)</sup>

(V<sub>CC</sub> = 5.0V ± 10%, V<sub>LC</sub> = 0.2V, V<sub>HC</sub> = V<sub>CC</sub> - 0.2V)

Symbol	Parameter	Power	6168SA25 6168LA25		6168SA35 6168LA35		6168SA45 6168LA45		Unit
			Com'l.	Mil.	Com'l.	Mil.	Com'l.	Mil.	
ICC1	Operating Power Supply Current $\overline{CS} \leq V_{IL}$ , Outputs Open, V <sub>CC</sub> = Max., f = 0 <sup>(2)</sup>	SA	90	100	90	—	—	100	mA
		LA	70	80	70	—	—	80	
ICC2	Dynamic Operating Current $\overline{CS} \leq V_{IL}$ , Outputs Open, V <sub>CC</sub> = Max., f = f <sub>MAX</sub> <sup>(2)</sup>	SA	110	120	100	—	—	110	mA
		LA	90	100	80	—	—	80	
ISB	Standby Power Supply Current (TTL Level) $\overline{CS} \geq V_{IH}$ , V <sub>CC</sub> = Max., Outputs Open, f = f <sub>MAX</sub> <sup>(2)</sup>	SA	35	45	30	—	—	35	mA
		LA	25	30	20	—	—	25	
ISB1	Full Standby Power Supply Current (CMOS Level) $\overline{CS} \geq V_{HC}$ , V <sub>CC</sub> = Max., V <sub>IN</sub> ≥ V <sub>HC</sub> or V <sub>IN</sub> ≤ V <sub>LC</sub> , f = 0 <sup>(2)</sup>	SA	3	10	3	—	—	10	mA
		LA	0.5	0.3	0.5	—	—	0.3	

**NOTES:**

- All values are maximum guaranteed values.
- f<sub>MAX</sub> = 1/trc, only address inputs are cycling at f<sub>MAX</sub>. f = 0 means no address inputs are changing.

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### DC ELECTRICAL CHARACTERISTICS V<sub>CC</sub> = 5.0V ± 10%

Symbol	Parameter	Test Condition	IDT6168SA		IDT6168LA		Unit	
			Min.	Max.	Min.	Max.		
I <sub>LI</sub>	Input Leakage Current	V <sub>CC</sub> = Max., V <sub>IN</sub> = GND to V <sub>CC</sub>	MIL	—	10	—	5	μA
			COM'L	—	2	—	2	
I <sub>LO</sub>	Output Leakage Current	V <sub>CC</sub> = Max., $\overline{CS} = V_{IH}$ , V <sub>OUT</sub> = GND to V <sub>CC</sub>	MIL	—	10	—	5	μA
			COM'L	—	2	—	2	
V <sub>OL</sub>	Output LOW Voltage	I <sub>OL</sub> = 10mA, V <sub>CC</sub> = Min.		—	0.5	—	0.5	V
				—	0.4	—	0.4	
V <sub>OH</sub>	Output HIGH Voltage	I <sub>OH</sub> = -4mA, V <sub>CC</sub> = Min.		2.4	—	2.4	—	V

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### DATA RETENTION CHARACTERISTICS (LA Version Only)

$V_{LC} = 0.2V, V_{HC} = V_{CC} - 0.2V$

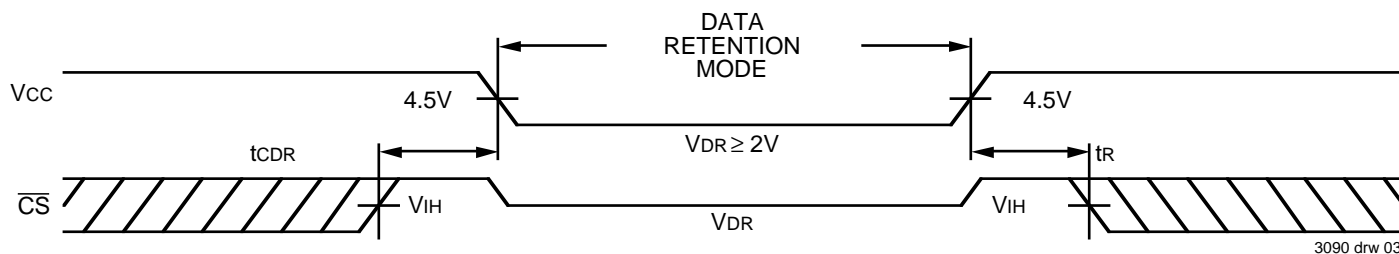
Symbol	Parameter	Test Condition	IDT6168LA			Unit	
			Min.	Typ. <sup>(1)</sup>	Max.		
VDR	VCC for Data Retention	$\overline{CS} \geq V_{HC}$ $V_{IN} \geq V_{HC}$ or $\leq V_{LC}$	2.0	—	—	V	
ICCDR	Data Retention Current		MIL.	—	0.5 <sup>(2)</sup>	100 <sup>(2)</sup>	$\mu A$
			COM'L.	—	1.0 <sup>(3)</sup>	150 <sup>(3)</sup>	$\mu A$
tCDR <sup>(5)</sup>	Chip Deselect to Data Retention Time		0	—	—	ns	
tR <sup>(5)</sup>	Operation Recovery Time		tRC <sup>(2)</sup>	—	—	ns	

**NOTES:**

1.  $T_A = +25^\circ C$ .
2. at  $V_{CC} = 2V$
3. at  $V_{CC} = 3V$
4. tRC = Read Cycle Time.
5. This parameter is guaranteed by device characterization, but is not production tested.

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### LOW VCC DATA RETENTION WAVEFORM

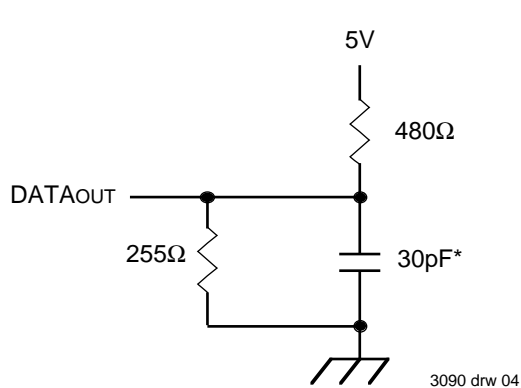


3090 drw 03

### AC TEST CONDITIONS

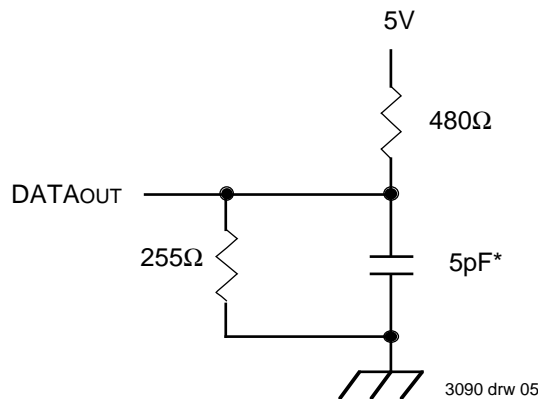
Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	5ns
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
AC Test Load	See Figures 1 and 2

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3090 drw 04

Figure 1. AC Test Load



3090 drw 05

Figure 2. AC Test Load  
(for tCHZ, tCLZ, tWHZ and tOW)

\*Includes scope and jig capacitances

**AC ELECTRICAL CHARACTERISTICS (CONTINUED)** ( $V_{CC} = 5.0V \pm 10\%$ , All Temperature Ranges)

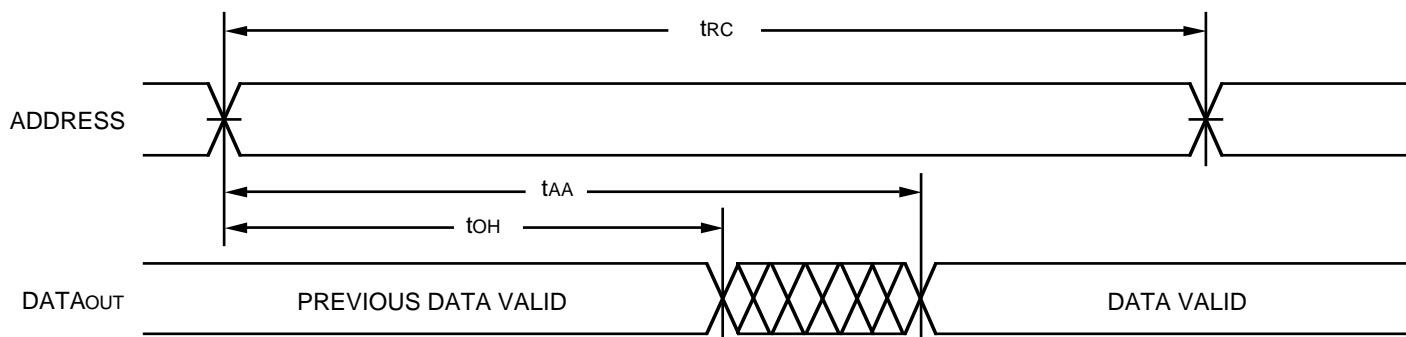
Symbol	Parameter	6168SA15		6168SA20/25 6168LA20/25		6168SA35 6168LA35		6168SA45 <sup>(1)</sup> 6168LA45 <sup>(1)</sup>		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>Read Cycle</b>										
t <sub>RC</sub>	Read Cycle Time	15	—	20/25	—	35	—	45	—	ns
t <sub>AA</sub>	Address Access Time	—	15	—	20/25	—	35	—	45	ns
t <sub>ACS</sub>	Chip Select Access Time	—	15	—	20/25	—	35	—	45	ns
t <sub>CLZ</sub> <sup>(2)</sup>	Chip Select to Output in Low-Z	3	—	5	—	5	—	5	—	ns
t <sub>CHZ</sub> <sup>(2)</sup>	Chip Deselect to Output in High-Z	—	8	—	10	—	15	—	25	ns
t <sub>OH</sub>	Output Hold from Address Change	3	—	3	—	3	—	3	—	ns
t <sub>PU</sub> <sup>(2)</sup>	Chip Select to Power-Up Time	0	—	0	—	0	—	0	—	ns
t <sub>PD</sub> <sup>(2)</sup>	Chip Deselect to Power-Down Time	—	35	—	20/25	—	35	—	40	ns

**NOTES:**

1. -55°C to +125°C temperature range only.
2. This parameter is guaranteed with AC Test load (Figure 2) by device characterization, but is not production tested.

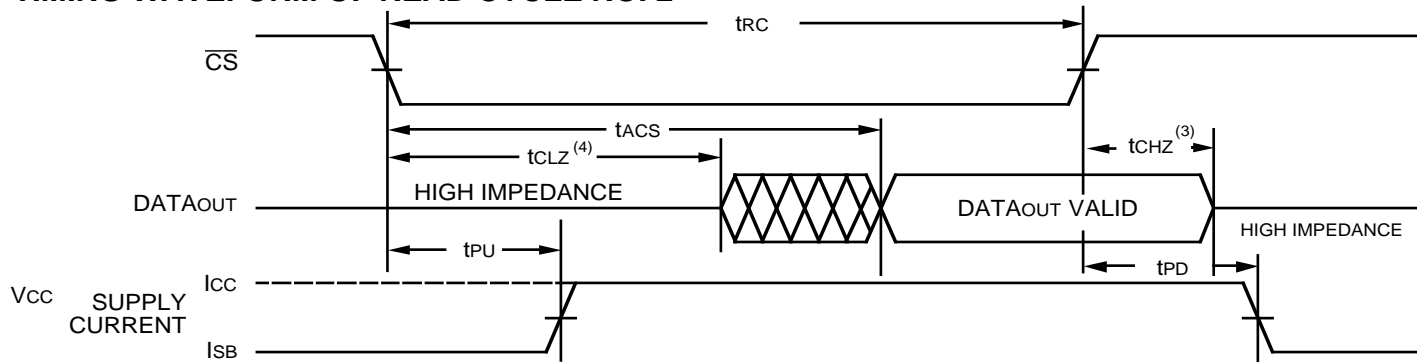
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**TIMING WAVEFORM OF READ CYCLE NO. 1<sup>(1, 2)</sup>**



3090 drw 06

**TIMING WAVEFORM OF READ CYCLE NO. 2<sup>(1, 3)</sup>**



3090 drw 07

**NOTES:**

1. WE is HIGH for Read cycle.
2. CS is LOW for Read cycle.
3. Device is continuously selected, CS is LOW.
3. Address valid prior to or coincident with CS transition LOW.
4. Transition is measured ±200mV from steady state.

**AC ELECTRICAL CHARACTERISTICS (CONTINUED)** ( $V_{CC} = 5.0V \pm 10\%$ , All Temperature Ranges)

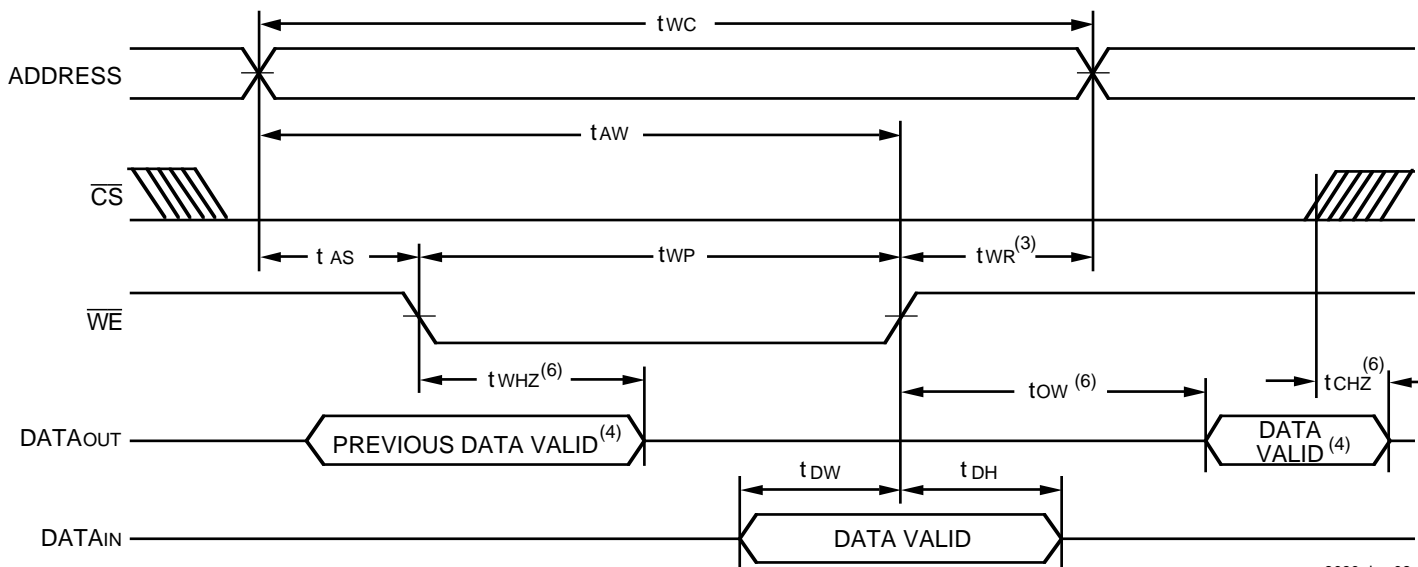
Symbol	Parameter	6168SA15		6168SA20/25 6168LA20/25		6168SA35 6168LA35		6168SA45 <sup>(2)</sup> 6168LA45 <sup>(2)</sup>		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>Write Cycle</b>										
t <sub>WC</sub>	Write Cycle Time	15	—	20	—	30	—	40	—	ns
t <sub>CW</sub>	Chip Select to End-of-Write	15	—	20	—	30	—	40	—	ns
t <sub>AW</sub>	Address Valid to End-of-Write	15	—	20	—	30	—	40	—	ns
t <sub>AS</sub>	Address Set-up Time	0	—	0	—	0	—	0	—	ns
t <sub>WP</sub>	Write Pulse Width	15	—	20	—	30	—	40	—	ns
t <sub>WR</sub>	Write Recovery Time	0	—	0	—	0	—	0	—	ns
t <sub>DW</sub>	DataValid to End-of-Write	9	—	10	—	15	—	20	—	ns
t <sub>DH</sub>	Data Hold Time	0	—	0	—	0	—	3	—	ns
t <sub>WHZ</sub> <sup>(3)</sup>	Write Enable to Output in High-Z	—	6	—	7	—	13	—	20	ns
t <sub>OW</sub> <sup>(3)</sup>	Output Active from End-of-Write	0	—	0	—	0	—	0	—	ns

**NOTES:**

1. 0° to +70°C temperature range only.
2. -55°C to +125°C temperature range only.
3. This parameter is guaranteed with the AC Load (Figure 2) by device characterization, but is not production tested.

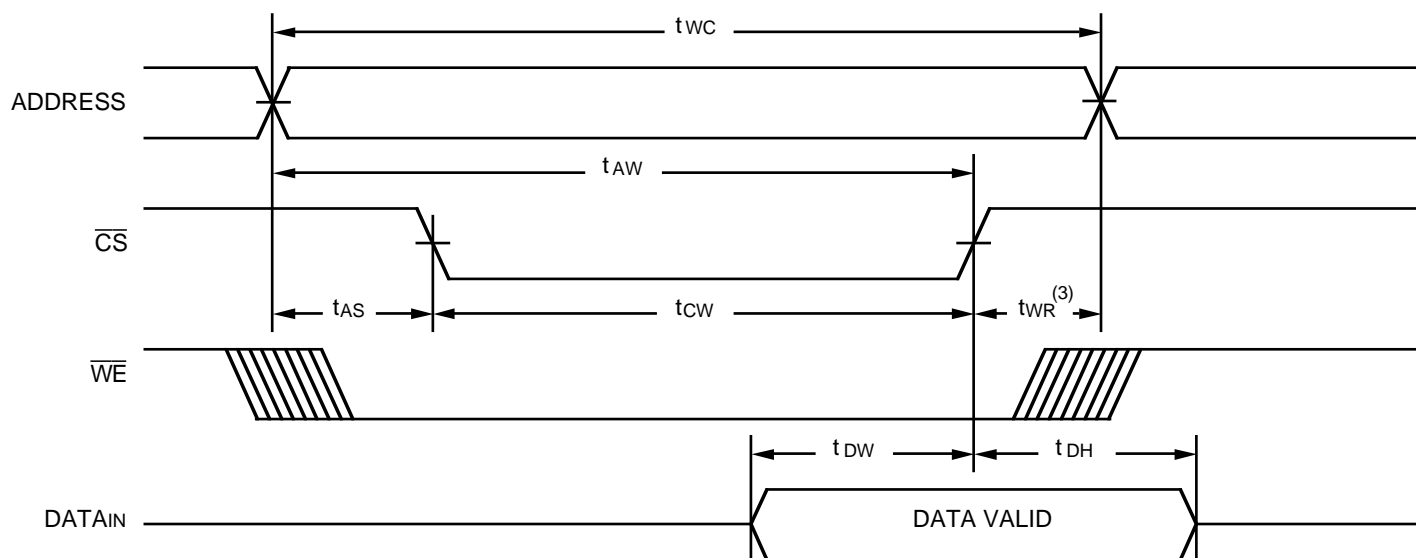
3090 tbl 13

**TIMING WAVEFORM OF WRITE CYCLE NO. 1 ( $\overline{WE}$  CONTROLLED TIMING)<sup>(1, 2, 5)</sup>**



3090 drw 08

**TIMING WAVEFORM OF WRITE CYCLE NO. 2 ( $\overline{CS}$  CONTROLLED TIMING)<sup>(1, 2, 5)</sup>**



3090 drw 09

**NOTES:**

1.  $\overline{WE}$  or  $\overline{CS}$  must be HIGH during all address transitions.
2. A write occurs during the overlap of a LOW  $\overline{CS}$  and a LOW  $\overline{WE}$ .
3.  $t_{WR}$  is measured from the earlier of  $\overline{CS}$  or  $\overline{WE}$  going HIGH to the end of the write cycle.
4. During this period, the I/O pins are in the output state and input signals should not be applied.
5. If the  $\overline{CS}$  LOW transition occurs simultaneously with or after the  $\overline{WE}$  LOW transition, the outputs remain in the high impedance state.
6. Transition is measured  $\pm 200mV$  from steady state.

**ORDERING INFORMATION**

IDT 6168	XX	XXX	XX	X	
Device Type	Power	Speed	Package	Process/ Temperature Range	
				Blank B	Commercial (0°C to +70°C) Military (-55°C to +125°C) Compliant to MIL-STD-883, Class B
				P D SO	300mil Plastic DIP (P20-1) 300mil Ceramic DIP (D20-1) 300mil Small Outline IC, Gull Wing (SO20-2)
		15 20 25 35 45			} Speed in nanoseconds
				Military Only	
				SA LA	Standard Power Low Power

3090 drw 10